

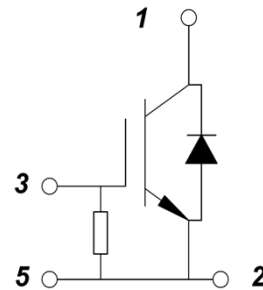
PRODUCT FEATURES

- IGBT³ CHIP(Trench+Field Stop technology)
- High short circuit capability,self limiting short circuit current
- $V_{CE(sat)}$ with positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Low switching losses
- 10K Ω Gate Protected Resistance Inside



APPLICATIONS

- High Power Converters
- Medical applications
- Motion/servo control
- UPS systems/Wind Turbines



IGBT-Inverter

ABSOLUTE MAXIMUM RATINGS

$T_C = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions		Values	Unit
V_{CES}	Collector Emitter Voltage	$T_J = 25^\circ\text{C}$	1200	V
V_{GES}	Gate Emitter Voltage		± 20	
I_C	DC Collector Current	$T_C = 25^\circ\text{C}$	580	A
		$T_C = 80^\circ\text{C}$	400	
I_{CM}	Repetitive Peak Collector Current	$t_p = 1\text{ms}$	800	
P_{tot}	Power Dissipation Per IGBT		1925	W

Reverse-Diode

ABSOLUTE MAXIMUM RATINGS

$T_C = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_J = 25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_C = 25^\circ\text{C}$	400	A
I_{FRM}	Repetitive Peak Forward Current	$t_p = 1\text{ms}$	800	
i^2t		$T_J = 125^\circ\text{C}$, $t = 10\text{ms}$, $V_R = 0\text{V}$	30000	A^2S

IGBT-Inverter

ELECTRICAL CHARACTERISTICS

$T_C = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=16\text{mA}$	5.0	5.8	6.5	V	
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=400\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.7	2.15		
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		1.9			
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			1	mA	
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=125^\circ\text{C}$			10	mA	
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 15\text{V}, T_J=25^\circ\text{C}$	-400		400	nA	
R_{gint}	Integrated Gate Resistor			1.9		Ω	
Q_g	Gate Charge	$V_{CE}=600\text{V}, I_C=400\text{A}, V_{GE}=\pm 15\text{V}$		3.8		μC	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		28		nF	
C_{res}	Reverse Transfer Capacitance				1000		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=400\text{A}$ $R_G=1.8\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		160		ns
			$T_J=125^\circ\text{C}$		170		ns
t_r	Rise Time		$T_J=25^\circ\text{C}$		40		ns
			$T_J=125^\circ\text{C}$		45		ns
$t_{d(off)}$	Turn off Delay Time	$V_{CC}=600\text{V}, I_C=400\text{A}$ $R_G=1.8\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		450		ns
			$T_J=125^\circ\text{C}$		520		ns
t_f	Fall Time		$T_J=25^\circ\text{C}$		100		ns
			$T_J=125^\circ\text{C}$		160		ns
E_{on}	Turn on Energy	$V_{CC}=600\text{V}, I_C=400\text{A}$ $R_G=1.8\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		20		mJ
			$T_J=125^\circ\text{C}$		30		mJ
E_{off}	Turn off Energy		$T_J=25^\circ\text{C}$		33		mJ
			$T_J=125^\circ\text{C}$		50.0		mJ
I_{sc}	Short Circuit Current	$t_{psc} \leq 10\mu\text{s}, V_{GE}=15\text{V}$ $T_J=125^\circ\text{C}, V_{CC}=900\text{V}$		1550		A	
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.065	K /W	

Reverse-Diode

ELECTRICAL CHARACTERISTICS

$T_C = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F=400\text{A}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$		1.65	2.15	V
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_J=125^\circ\text{C}$		1.65		
t_{rr}	Reverse Recovery Time	$I_F=400\text{A}, V_R=600\text{V}$		360		ns
I_{RRM}	Max. Reverse Recovery Current	$di_F/dt=-8000\text{A}/\mu\text{s}$		450		A
Q_{RR}	Reverse Recovery Charge	$T_J=125^\circ\text{C}$		75		μC
E_{rec}	Reverse Recovery Energy			35		mJ
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)				0.12	K /W

MODULE CHARACTERISTICS

$T_C=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions		Values	Unit
T_{Jmax}	Max. Junction Temperature		150	°C
T_{Jop}	Operating Temperature		-40~125	
T_{stg}	Storage Temperature		-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	3000	V
Torque	to heatsink	Recommended (M6)	3~5	Nm
	to terminal	Recommended (M6)	2.5~5	Nm
	to terminal	Recommended (M4)	0.7~1.1	Nm
Weight			330	g

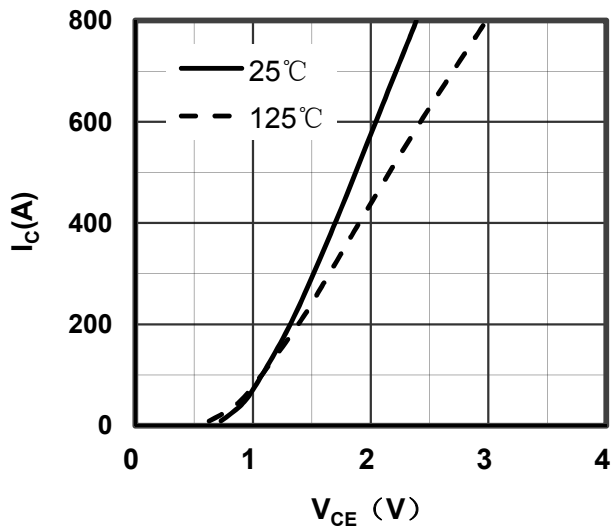


Figure 1. Typical Output Characteristics IGBT-Inverter

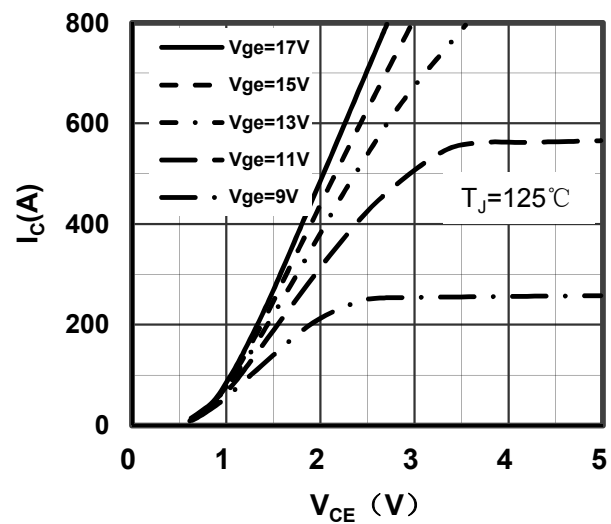


Figure 2. Typical Output Characteristics IGBT-Inverter

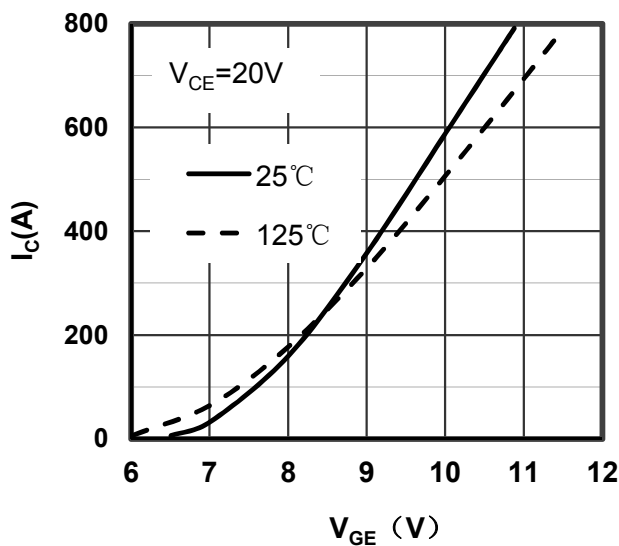


Figure 3. Typical Transfer characteristics IGBT-Inverter

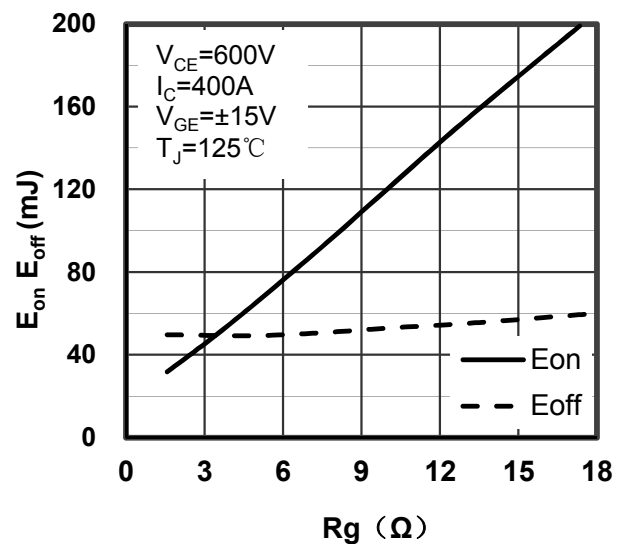


Figure 4. Switching Energy vs Gate Resistor IGBT-Inverter

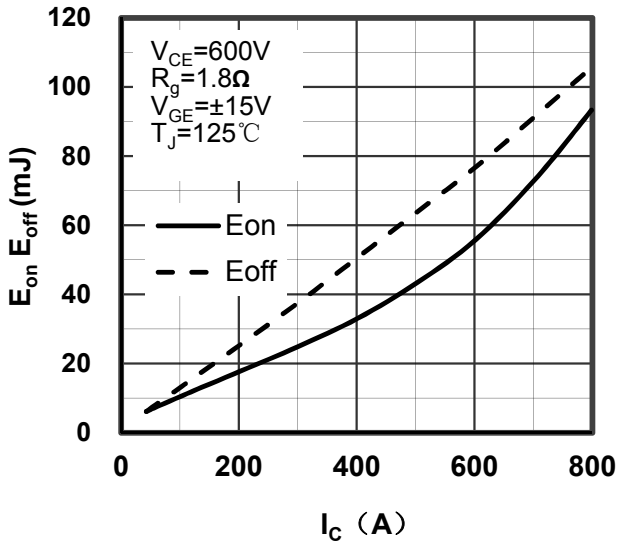


Figure 5. Switching Energy vs Collector Current IGBT-Inverter

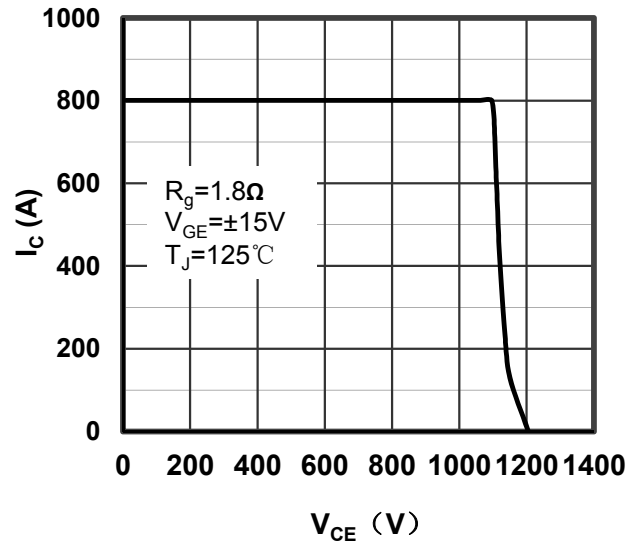


Figure 6. Reverse Biased Safe Operating Area IGBT-Inverter

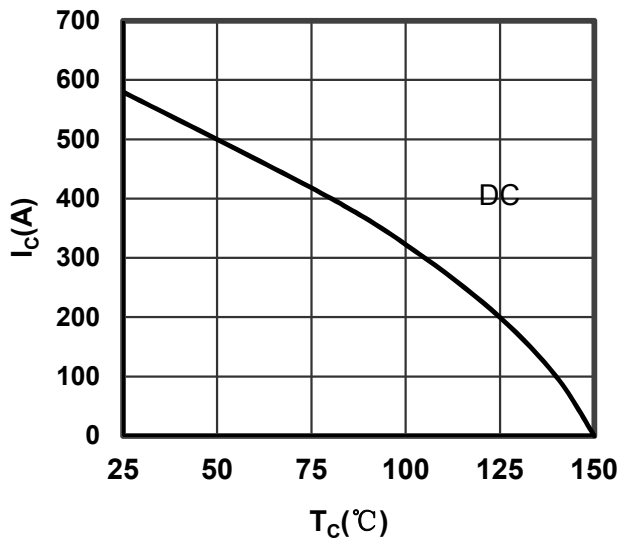


Figure 7. Collector Current vs Case temperature IGBT-Inverter

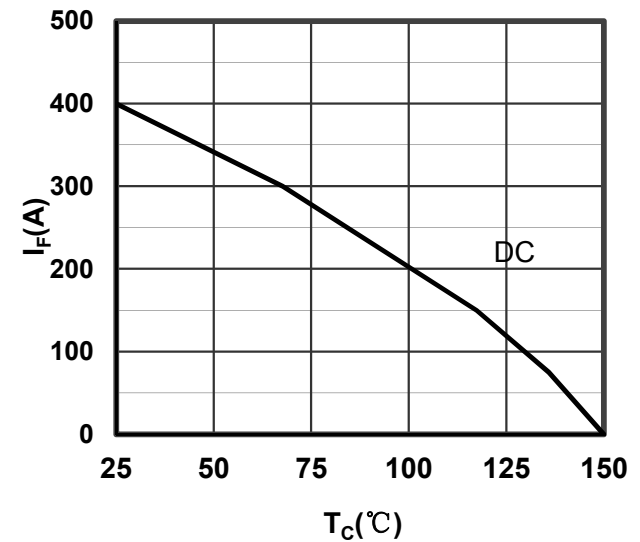


Figure 8. Forward current vs Case temperature Reverse-Diode

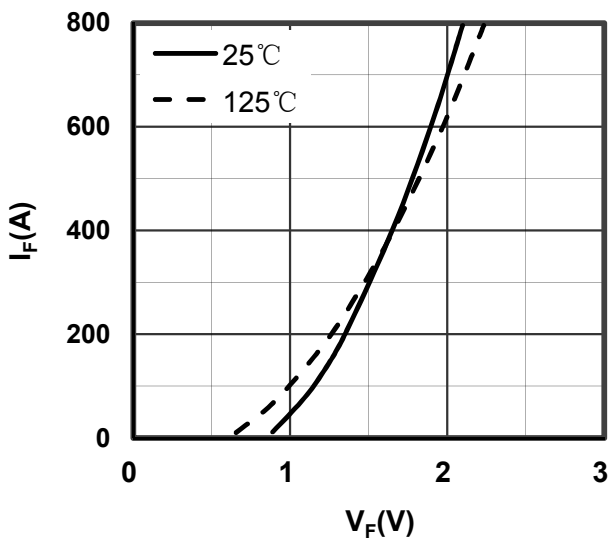


Figure 9. Diode Forward Characteristics Reverse-Diode

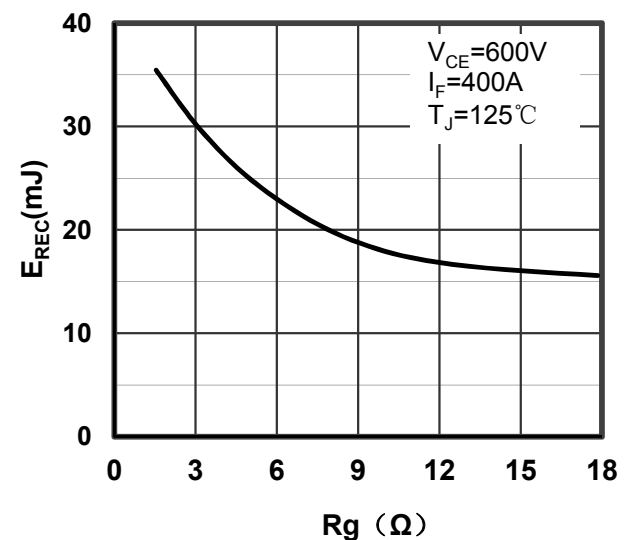


Figure 10. Switching Energy vs Gate Resistor Reverse-Diode

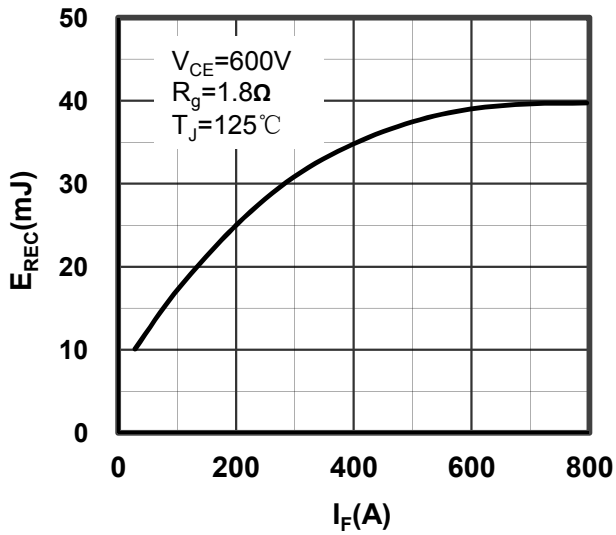


Figure 11. Switching Energy vs Forward Current Reverse-Diode

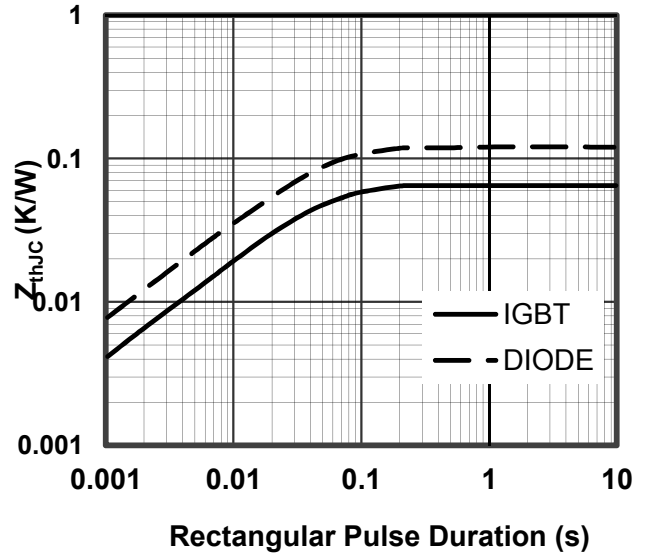
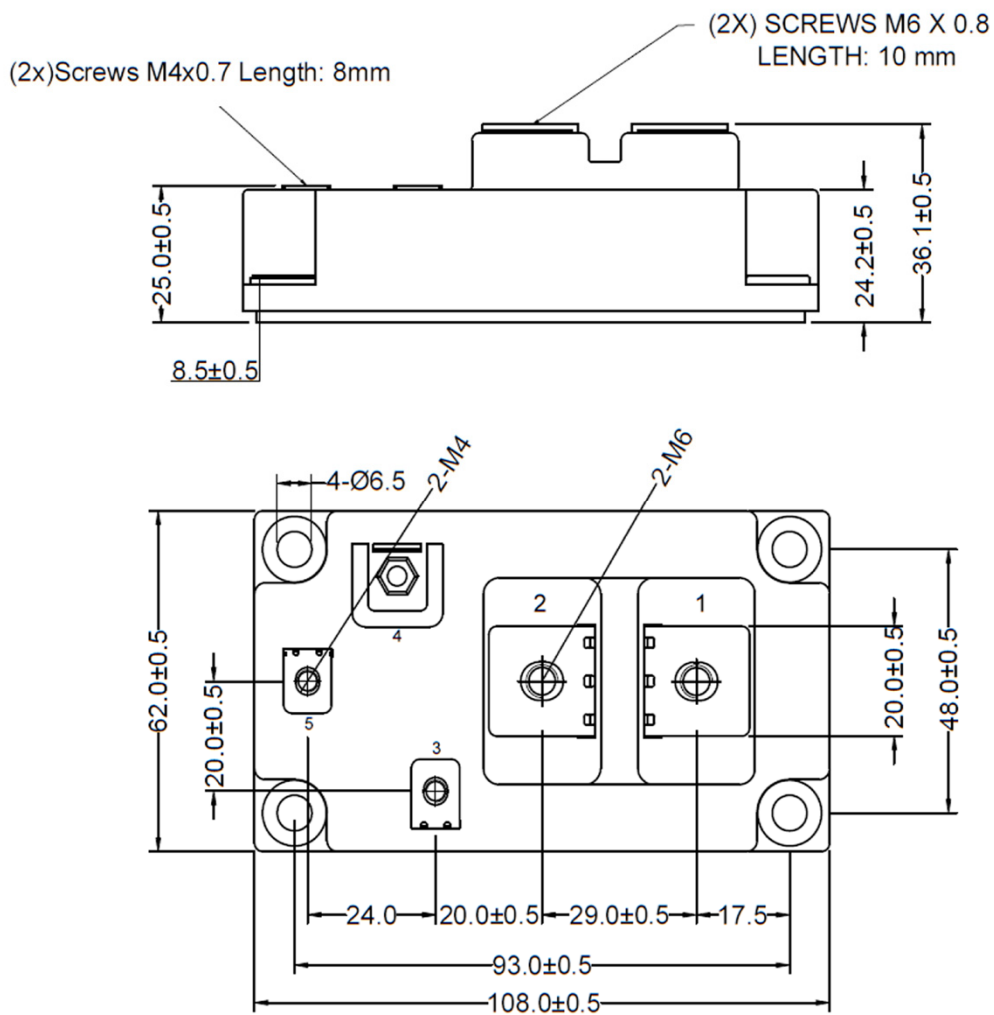


Figure 12. Transient Thermal Impedance of IGBT-Inverter and Reverse-Diode



Dimensions in (mm)
Figure 13. Package Outline